

## High Temperature Silicon Carbide Power Schottky Diode

|                                  |   |       |
|----------------------------------|---|-------|
| $V_{RRM}$                        | = | 650 V |
| $I_F @ 25\text{ }^\circ\text{C}$ | = | 30 A  |
| $Q_C$                            | = | 66 nC |

### Features

- 650 V Schottky rectifier
- 210 °C maximum operating temperature
- Zero reverse recovery charge
- Superior surge current capability
- Positive temperature coefficient of  $V_F$
- Temperature independent switching behavior
- Lowest figure of merit  $Q_C/I_F$
- Available screened to Mil-PRF-19500



Die Size = 2.95 mm x 2.95 mm

### Advantages

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

### Applications

- Down Hole Oil Drilling
- Geothermal Instrumentation
- Solenoid Actuators
- General Purpose High-Temperature Switching
- Amplifiers
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)

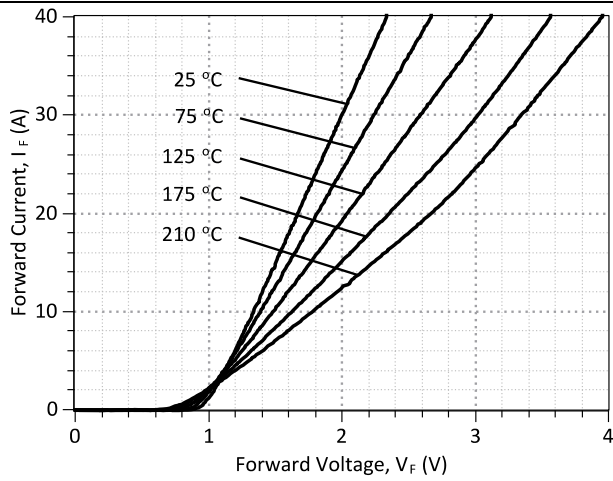
### Maximum Ratings at $T_j = 210\text{ }^\circ\text{C}$ , unless otherwise specified

| Parameter                                            | Symbol         | Conditions                                                       | Values |            | Unit                 |
|------------------------------------------------------|----------------|------------------------------------------------------------------|--------|------------|----------------------|
|                                                      |                |                                                                  | min.   | typ.       |                      |
| Repetitive peak reverse voltage                      | $V_{RRM}$      |                                                                  |        | 650        | V                    |
| Continuous forward current                           | $I_F$          | $T_C = 25\text{ }^\circ\text{C}$ , $R_{thJC} = 1.08$             |        | 30         | A                    |
| Continuous forward current                           | $I_F$          | $T_C \leq 190\text{ }^\circ\text{C}$ , $R_{thJC} = 1.08$         |        | 9.4        | A                    |
| RMS forward current                                  | $I_{F(RMS)}$   | $T_C \leq 190\text{ }^\circ\text{C}$ , $R_{thJC} = 1.08$         |        | 16         | A                    |
| Surge non-repetitive forward current, Half Sine Wave | $I_{F,SM}$     | $T_C = 25\text{ }^\circ\text{C}$ , $t_p = 10\text{ ms}$          |        | 140        | A                    |
| Non-repetitive peak forward current                  | $I_{F,max}$    | $T_C = 25\text{ }^\circ\text{C}$ , $t_p = 10\text{ }\mu\text{s}$ |        | 650        | A                    |
| $I^2t$ value                                         | $\int j^2 dt$  | $T_C = 25\text{ }^\circ\text{C}$ , $t_p = 10\text{ ms}$          |        | 98         | $\text{A}^2\text{S}$ |
| Power dissipation                                    | $P_{tot}$      | $T_C = 25\text{ }^\circ\text{C}$ , $R_{thJC} = 1.08$             |        | 208        | W                    |
| Operating and storage temperature                    | $T_j, T_{stg}$ |                                                                  |        | -55 to 210 | $^\circ\text{C}$     |

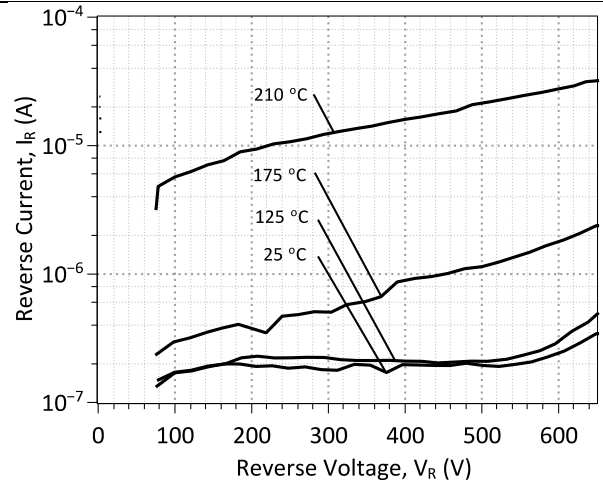
### Electrical Characteristics at $T_j = 210\text{ }^\circ\text{C}$ , unless otherwise specified

| Parameter               | Symbol | Conditions                                                                                        | Values |      |      | Unit          |
|-------------------------|--------|---------------------------------------------------------------------------------------------------|--------|------|------|---------------|
|                         |        |                                                                                                   | min.   | typ. | max. |               |
| Diode forward voltage   | $V_F$  | $I_F = 10\text{ A}$ , $T_j = 25\text{ }^\circ\text{C}$                                            |        | 1.3  |      | V             |
|                         |        | $I_F = 10\text{ A}$ , $T_j = 210\text{ }^\circ\text{C}$                                           |        | 1.8  |      |               |
| Reverse current         | $I_R$  | $V_R = 650\text{ V}$ , $T_j = 25\text{ }^\circ\text{C}$                                           |        | 1    | 5    | $\mu\text{A}$ |
|                         |        | $V_R = 650\text{ V}$ , $T_j = 210\text{ }^\circ\text{C}$                                          |        | 50   | 200  |               |
| Total capacitive charge | $Q_C$  | $I_F \leq I_{F,MAX}$<br>$dI_F/dt = 200\text{ A}/\mu\text{s}$<br>$T_j = 210\text{ }^\circ\text{C}$ |        | 66   |      | nC            |
| Switching time          | $t_s$  | $V_R = 400\text{ V}$                                                                              |        | < 49 |      | ns            |
|                         |        | $V_R = 400\text{ V}$                                                                              |        | < 49 |      |               |
| Total capacitance       | C      | $V_R = 1\text{ V}$ , $f = 1\text{ MHz}$ , $T_j = 25\text{ }^\circ\text{C}$                        |        | 1107 |      | pF            |
|                         |        | $V_R = 400\text{ V}$ , $f = 1\text{ MHz}$ , $T_j = 25\text{ }^\circ\text{C}$                      |        | 103  |      |               |
|                         |        | $V_R = 650\text{ V}$ , $f = 1\text{ MHz}$ , $T_j = 25\text{ }^\circ\text{C}$                      |        | 99   |      |               |

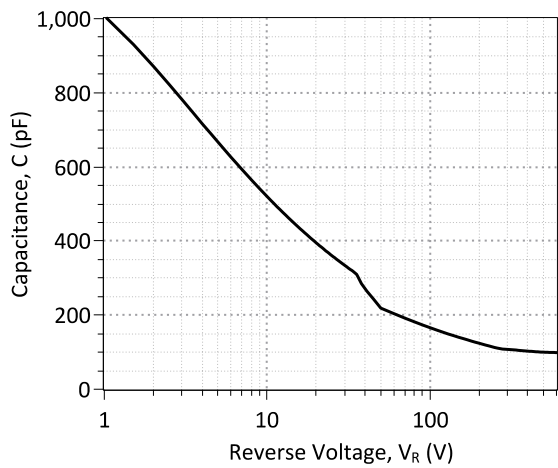
**Figures:**



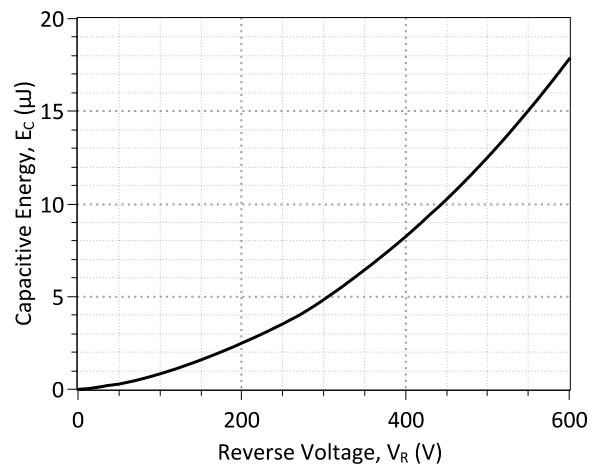
**Figure 1: Typical Forward Characteristics**



**Figure 2: Typical Reverse Characteristics**



**Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics**

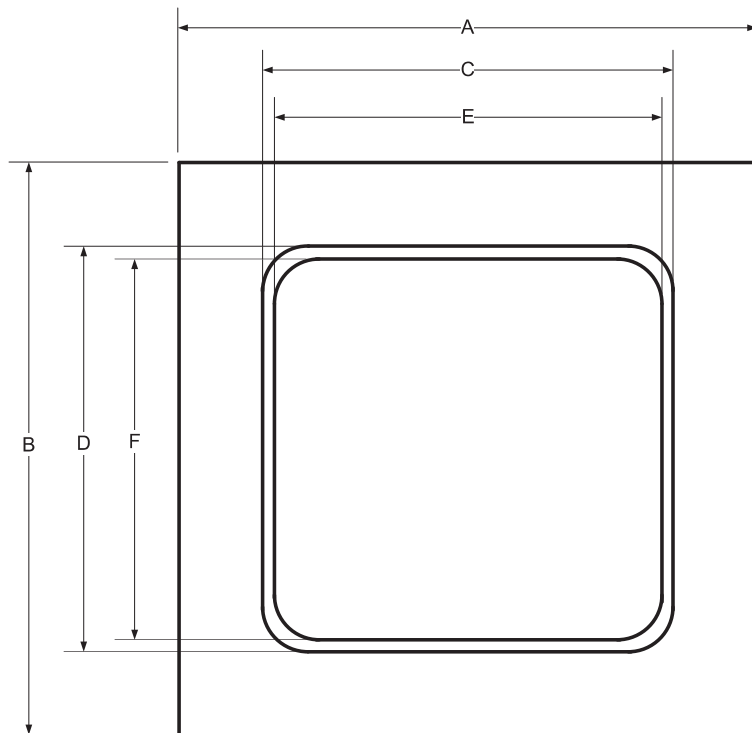


**Figure 4: Typical Capacitive Energy vs Reverse Voltage Characteristics**

**Mechanical Parameters**

|                                 |                                                                                                |                 |
|---------------------------------|------------------------------------------------------------------------------------------------|-----------------|
| Die Dimensions                  | 2.95 x 2.95                                                                                    | mm <sup>2</sup> |
| Anode pad size                  | 2.69 x 2.69                                                                                    |                 |
| Die Area total / active         | 8.70/7.02                                                                                      |                 |
| Die Thickness                   | 360                                                                                            | µm              |
| Wafer Size                      | 100                                                                                            | mm              |
| Flat Position                   | 0                                                                                              | deg             |
| Die Frontside Passivation       | Polyimide                                                                                      |                 |
| Anode Pad Metallization         | 4000 nm Al                                                                                     |                 |
| Backside Cathode Metallization  | 400 nm Ni + 200 nm Au                                                                          |                 |
| Die Attach                      | Electrically conductive glue or solder                                                         |                 |
| Wire Bond                       | Al ≤ 380 µm                                                                                    |                 |
| Reject ink dot size             | Φ ≥ 0.3 mm                                                                                     |                 |
| Recommended storage environment | Store in original container, in dry nitrogen,<br>< 6 months at an ambient temperature of 23 °C |                 |

**Chip Dimensions:**



|                      |        |      |
|----------------------|--------|------|
| <b>DIE</b>           | A [mm] | 2.95 |
|                      | B [mm] | 2.95 |
| <b>METAL</b>         | C [mm] | 2.69 |
|                      | D [mm] | 2.69 |
| <b>WIRE BONDABLE</b> | E [mm] | 2.65 |
|                      | F [mm] | 2.65 |

**Revision History**

| Date       | Revision | Comments                       | Supersedes |
|------------|----------|--------------------------------|------------|
| 2015/02/09 | 1        | Inserted Mechanical Parameters |            |
| 2012/04/03 | 0        | Initial release                |            |

## Published by

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## SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website ([http://www.genesicsemi.com/images/hit\\_sic/baredie/schottky/GB20SHT06-CAL\\_SPICE.pdf](http://www.genesicsemi.com/images/hit_sic/baredie/schottky/GB20SHT06-CAL_SPICE.pdf)) into LTSPICE (version 4) software for simulation of the GB20SHT06-CAL.

```
*      MODEL OF GeneSiC Semiconductor Inc.
*
*      $Revision:   1.0           $
*      $Date:      05-SEP-2013   $
*
*      GeneSiC Semiconductor Inc.
*      43670 Trade Center Place Ste. 155
*      Dulles, VA 20166
*
*      COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
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*      These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
*      OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
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*      PARTICULAR PURPOSE."
*      Models accurate up to 2 times rated drain current.
*
*      Start of GB20SHT06-CAL SPICE Model
*
.SUBCKT GB20SHT06 ANODE KATHODE
D1 ANODE KATHODE GB20SHT06_25C; Call the Schottky Diode Model
D2 ANODE KATHODE GB20SHT06_PIN; Call the PiN Diode Model
.MODEL GB20SHT06_25C D
+ IS      8.46E-17      RS      0.0319
+ N       1            IKF     1000
+ EG      1.2          XTI     3
+ TRS1    0.0038       TRS2    3.00E-05
+ CJO     1.26E-09     VJ      0.438
+ M       1.5278       FC      0.5
+ TT      1.00E-10     BV      650
+ IBV     1.00E-03     VPK     650
+ IAVE    20           TYPE    SiC_Schottky
+ MFG     GeneSiC_Semiconductor
.MODEL GB20SHT06_PIN D
+ IS      2.77E-10     RS      0.086693
+ N       3.3505      IKF     3.67E-06
+ EG      3.23        XTI     -10
+ FC      0.5         TT      0
+ BV      650         IBV     1.00E-03
+ VPK     650         IAVE    20
+ TYPE    SiC_PiN
.ENDS
*
*      End of GB20SHT06-CAL SPICE Model
```